

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination	
			10/563,181	MILIAN LAMPIC-OPLANDER	
			Examiner	Art Unit	Page 1 of 1
			Deborah Yee	1793	

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	E	US-			
	F	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.